

Order

Now





SCDS263D-SEPTEMBER 2009-REVISED SEPTEMBER 2019

Support &

Community

20

TS3USB221E High-Speed USB 2.0 (480-Mbps) 1:2 Multiplexer – Demultiplexer Switch With Single Enable and IEC Level 3 ESD Protection

Technical

Documents

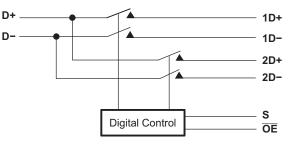
1 Features

- V_{CC} operation of 2.3 V to 3.6 V
- Switch I/Os accept signals up to 5.5 V
- 1.8-V compatible control-pin inputs
- Low-power mode when \overline{OE} Is disabled (1 μ A)
- $r_{ON} = 6 \Omega$ maximum
- $\Delta r_{ON} = 0.2 \Omega$ typical
- C_{io(on)} = 7 pF maximum
- Low power consumption (30 μA maximum)
- ESD performance tested per JESD 22
 - 7000-V human body model (A114-B, Class II)
 - 1000-V charged-device model (C101)
- ESD performance I/O port to GND
 - 12-kV human body model (A114-B, Class II)
 - ±7-kV contact discharge (IEC 61000-4-2)
- High bandwidth (1 GHz typical)

2 Applications

- Routes signals for USB 1.0, 1.1, and 2.0
- Mobile phones
- Digital cameras
- Notebooks
- USB I/O expansion
- MHL 1.0

Block Diagram



3 Description

Tools &

Software

The TS3USB221E is a high-bandwidth switch specially designed for the switching of high-speed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (1 GHz) of this switch allows signals to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The TS3USB221E is designed for low bit-tobit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480 Mbps).

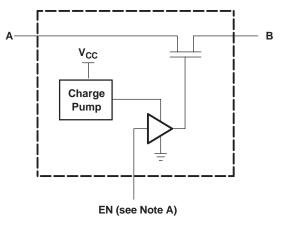
The TS3USB221E integrates ESD protection cells on all pins, is available in a SON package (3 mm × 3 mm) as well as in a tiny μ QFN package (2 mm × 1.5 mm) and is characterized over the free-air temperature range from -40°C to 85°C.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TS3USB221E	VSON (10)	3.00 mm × 3.00 mm
13303D221E	UQFN (10)	1.50 mm × 2.00 mm

 For all available packages, see the orderable addendum at the end of the data sheet.

Simplified Schematic, Each FET Switch (SW)



A. EN is the internal enable signal applied to the switch.



Features 1

Applications 1 Description 1

Revision History..... 2

Pin Configuration and Functions 3

Specifications...... 4 6.1 Absolute Maximum Ratings 4 ESD Ratings..... 4

6.4 Thermal Information 5 6.5 Electrical Characteristics 5 6.6 Dynamic Electrical Characteristics, $V_{CC} = 3.3 V$

6.7 Dynamic Electrical Characteristics, V_{CC} = 2.5 V

Recommended Operating Conditions 4

6.10 Typical Characteristics 7

Detailed Description 12

	8.1	Overview 12
	8.2	Functional Block Diagram 12
	8.3	Feature Description 12
	8.4	Device Functional Modes 12
9	Арр	lication and Implementation 13
	9.1	Application Information 13
	9.2	Typical Application 13
10	Pow	ver Supply Recommendations 15
11	Lay	out 15
	11.1	Layout Guidelines 15
	11.2	Layout Example 16
12	Dev	ice and Documentation Support 17
	12.1	Documentation Support 17
	12.2	Receiving Notification of Documentation Updates 17
	12.3	Support Resources 17
	12.4	Trademarks 17
	12.5	Electrostatic Discharge Caution 17
	12.6	Glossary 17
13	Mec	hanical, Packaging, and Orderable
		rmation 17

4 Revision History

1

2

3 4

5

6

7

8

2

6.2

6.3

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

C	Changes from Revision C (April 2015) to Revision D Page			
•	Changed V _{CC} Operation FROM 2.5 V to 3.3 V TO 2.3 V to 3.6 V	1		

Changes from Revision B (July 2012) to Revision C

•	Added Pin Configuration and Functions section, ESD Ratings table, Thermal Information table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section
•	Removed Ordering Information table 1

С	hanges from Revision A (February 2010) to Revision B	Page
•	Updated TOP-SIDE MARKING for RSE package in Ordering Information table	1

EXAS **STRUMENTS**

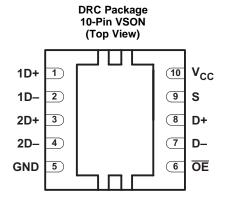
www.ti.com

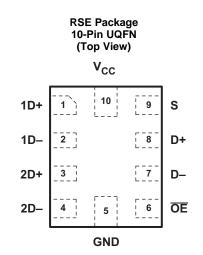
Page



TS3USB221E SCDS263D – SEPTEMBER 2009 – REVISED SEPTEMBER 2019

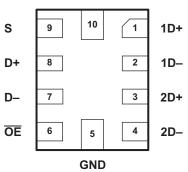
5 Pin Configuration and Functions





RSE Package 10-Pin UQFN (Bottom View)





Pin Functions

PIN		1/0	DESCRIPTION	
NAME	NO.	I/O	DESCRIPTION	
1D+	1	I/O	USB port 1	
1D-	2	I/O		
2D+	3	I/O	USB port 2	
2D-	4	I/O		
GND	5	_	Ground	
OE	6	I	Bus-switch enable	
D-	7	I/O	Common USB port	
D+	8	I/O		
S	9	I	Select input	
V _{CC}	10	_	Supply voltage	

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	4.6	V
V _{IN}	Control input voltage ⁽²⁾⁽³⁾		-0.5	7	V
V _{I/O}	Switch I/O voltage ⁽²⁾⁽³⁾⁽⁴⁾		-0.5	7	V
I _{IK}	Control input clamp current	V _{IN} < 0		-50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		-50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾			±120	mA
	Continuous current through V_{CC} or GND			±100	mA
0	Deckage thermal impedance (6)	DRC package		48.7	°C/W
θ_{JA}	Package thermal impedance ⁽⁶⁾ RSE package			243	0.00
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

(3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(4) V_I and V_O are used to denote specific conditions for $V_{I/O}$.

(5) I_{I} and I_{O} are used to denote specific conditions for $I_{I/O}$.

(6) The package thermal impedance is calculated in accordance with JESD 51-7.

6.2 ESD Ratings

				VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	All pins except GND, $\overline{\text{OE}},$ S and V_{CC}	±12000	
V	Electrostatic discharge		Pins GND, \overline{OE} , S and V _{CC}	±7000	V
V _(ESD)	5	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	All pins except GND, $\overline{\text{OE}},$ S and V_{CC}	±7000	v
		specification JESD22-C101 ⁽²⁾	Pins GND, \overline{OE} , S and V _{CC}	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

See (1).

			MIN	MAX	UNIT	
V _{CC}	Supply voltage		2.3	3.6	V	
V _{IH}		V_{CC} = 2.3 V to 2.7 V	$0.46 \times V_{CC}$			
	High-level control input voltage $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	V_{CC} = 2.7 V to 3.6 V	$0.46 \times V_{CC}$		v	
V _{IL}	Low-level control input voltage $\frac{V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}}{V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}}$			$0.25 \times V_{CC}$	V	
				$0.25 \times V_{CC}$	v	
V _{I/O}	Data input/output voltage		0	5.5	V	
T _A	Operating free-air temperature		-40	85	°C	

 All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, SCBA004.

6.4 Thermal Information

		TS3US	TS3USB221E		
	THERMAL METRIC ⁽¹⁾	DRC (VSON)	RSE (UQFN)	UNIT	
		10 PINS	10 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	57.7	169.8		
R _{0JC(top)}	Junction-to-case (top) thermal resistance	87.7	84.7		
$R_{\theta JB}$	Junction-to-board thermal resistance	32.6	94.9	°C/W	
ΨJT	Junction-to-top characterization parameter	8.2	5.7	C/W	
Ψјв	Junction-to-board characterization parameter	32.8	94.9		
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	18.5	N/A		

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARA	METER		TEST CONDITIONS		MIN	TYP ⁽²⁾	MAX	UNIT
V _{IK}		V _{CC} = 3.6 V, 2.7 V,	I _I = -18 mA				-1.8	V
I _{IN}	Control inputs	V_{CC} = 3.6 V, 2.7 V, 0 V,	$V_{IN} = 0 V \text{ to } 3.6 V$				±1	μA
$I_{OZ}^{(3)}$			$V_{IN} = V_{CC}$ or GND, Switch OFF				±1	μA
			$V_{I/O} = 0 V \text{ to } 5.25 V$				±2	
I _{OFF}		$V_{CC} = 0 V$	$V_{I/O} = 0 V \text{ to } 3.6 V$				±2	μA
			$V_{I/O} = 0 V \text{ to } 2.7 V$				±1	
I _{CC}		$\label{eq:VCC} \begin{array}{l} V_{CC} = 3.6 \ V, \ 2.7 \ V, \\ V_{IN} = V_{CC} \ \text{or GND}, \end{array}$	I _{I/O} = 0 V, Switch ON or OFF				30	μA
I _{CC} (low power mode)		$V_{CC} = 3.6 \text{ V}, 2.7 \text{ V},$ $V_{IN} = V_{CC} \text{ or GND}$	Switch disabled (OE in high state)				1	μΑ
I _{CC} ⁽⁴⁾	Control	One input at 1.8 V,	V _{CC} = 3.6 V				20	^
ICC (inputs	inputs Other inputs at V _{CC} or GND	$V_{CC} = 2.7 V$				0.5	μA
C _{in}	Control inputs	V _{CC} = 3.3 V, 2.5 V,	V_{IN} = 3.3 V or 0 V			1.5	2.5	pF
C _{io(OFF})		V _{CC} = 3.3 V, 2.5 V,	$V_{\rm I/O}=3.3~V~or~0~V,$	Switch OFF		3.5	5	pF
C _{io(ON)}		$V_{CC} = 3.3 V, 2.5 V,$	$V_{I/O} = 3.3 \text{ V or } 0 \text{ V},$	Switch ON		6	7.5	pF
r _{ON} ⁽⁵⁾		V _{CC} = 3 V, 2.3 V	$V_{I} = 0 V,$	I _O = 30 mA		3	6	Ω
ION Y		$v_{\rm CC} = 5 v, 2.5 v$	V _I = 2.4 V,	I _O = -15 mA		3.4	6	12
۸ r		V _{CC} = 3 V, 2.3 V	$V_{I} = 0 V,$	I _O = 30 mA		0.2		Ω
∆r _{ON}		V(() = 0 V, 2.0 V	V _I = 1.7,	I _O = -15 mA		0.2		32
r		V _{CC} = 3 V, 2.3 V	$V_I = 0 V,$	I _O = 30 mA		1		Ω
r _{ON(flat)}		v _{CC} = 5 v, 2.5 v	V _I = 1.7,	I _O = -15 mA		1		12

 V_{IN} and I_{IN} refer to control inputs. V_I , V_O , I_I , and I_O refer to data pins. All typical values are at $V_{CC} = 3.3$ V (unless otherwise noted), $T_A = 25$ C. For I/O ports, the parameter I_{OZ} includes the input leakage current. (1)

(2)

(3)

This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND. (4)

(5) Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.



6.6 Dynamic Electrical Characteristics, V_{cc} = 3.3 V ±10%

over operating range, $T_A = -40^{\circ}$ C to 85°C, $V_{CC} = 3.3 \text{ V} \pm 10\%$, GND = 0 V

	PARAMETER	TEST CONDITIONS	TYP ⁽¹⁾	UNIT				
X _{TALK}	Crosstalk	R _L = 50 , f = 250 MHz	-40	dB				
O _{IRR}	OFF isolation	R _L = 50 , f = 250 MHz	-40	dB				
BW	Bandwidth (-3 dB)	R _L = 50	1	GHz				

(1) For Maximum or Minimum conditions, use the appropriate value specified under *Electrical Characteristics* for the applicable device type.

6.7 Dynamic Electrical Characteristics, V_{cc} = 2.5 V ±10%

over operating range, $T_A = -40^{\circ}$ C to 85°C, $V_{CC} = 2.5$ V ±10%, GND = 0 V

	PARAMETER	TEST CONDITIONS	TYP ⁽¹⁾	UNIT
X _{TALK}	Crosstalk	R _L = 50 , f = 250 MHz	-39	dB
O _{IRR}	OFF isolation	R _L = 50 , f = 250 MHz	-40	dB
BW	Bandwidth (3 dB)	R _L = 50	1	GHz

(1) For Maximum or Minimum conditions, use the appropriate value specified under *Electrical Characteristics* for the applicable device type.

6.8 Switching Characteristics, V_{cc} = 3.3 V ±10%

over operating range, $T_A = -40^{\circ}$ C to 85°C, $V_{CC} = 3.3$ V ±10%, GND = 0 V

	PARAMETER	MIN	TYP ⁽¹⁾	MAX	UNIT	
t _{pd}	Propagation delay ^{(2) (3)}			0.25		ns
	Line enchle time	S to D, nD			30	
t _{ON}	Line enable time			17	ns	
		S to D, nD			12	
t _{OFF}	Line disable time			10	ns	
t _{SK(O)}	Output skew between center port to any other		0.1	0.2	ns	
t _{SK(P)}	Skew between opposite transitions of the sa		0.1	0.2	ns	

For Maximum or Minimum conditions, use the appropriate value specified under *Electrical Characteristics* for the applicable device type.
 Specified by design

(3) The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25 ns for 10-pF load. Because this time constant is much smaller than the rise/fall times of typical driving signals, it adds very little propagational delay to the system. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and its interactions with the load on the driven side.

6.9 Switching Characteristics, V_{cc} = 2.5 V ±10%

over operating range, $T_A = -40^{\circ}$ C to 85°C, $V_{CC} = 2.5$ V ±10%, GND = 0 V

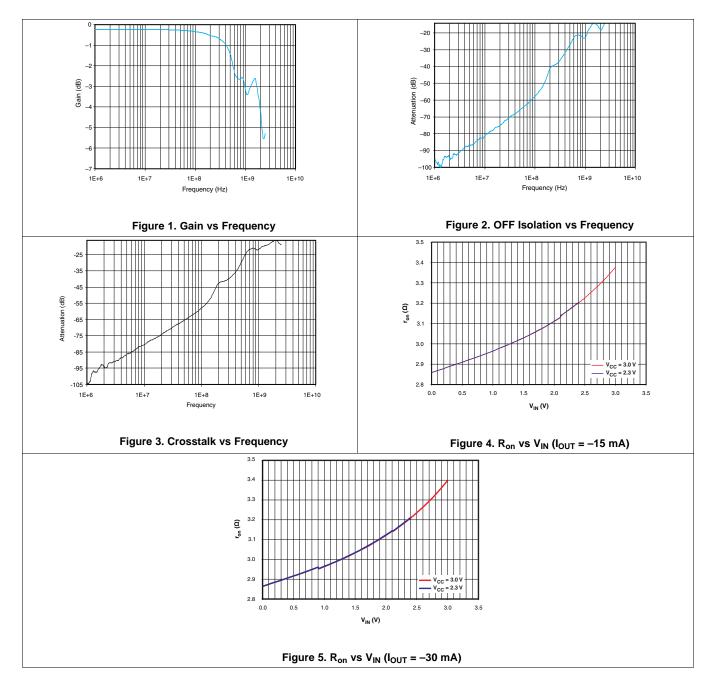
	PARAME	MIN	TYP ⁽¹⁾	MAX	UNIT	
t _{pd}	Propagation delay ^{(2) (3)}			0.25		ns
t _{ON} Line ena	Line enable time	S to D, nD			50	~~
		OE to D, nD			32	ns
t _{OFF}	the state of the state	S to D, nD			23	
	Line disable time OE to D, nD				12	ns
t _{SK(O)}	Output skew between center port to any		0.1	0.2	ns	
t _{SK(P)}	Skew between opposite transitions of the same output $\left(t_{PHL} - t_{PLH}\right)^{(2)}$			0.1	0.2	ns

(1) For Maximum or Minimum conditions, use the appropriate value specified under *Electrical Characteristics* for the applicable device type.
 (2) Specified by design

(3) The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25 ns for 10-pF load. Because this time constant is much smaller than the rise/fall times of typical driving signals, it adds very little propagational delay to the system. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and its interactions with the load on the driven side.

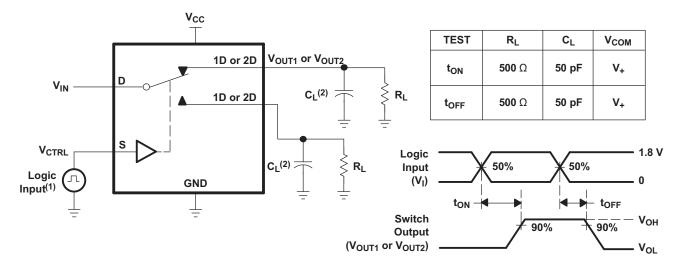


6.10 Typical Characteristics



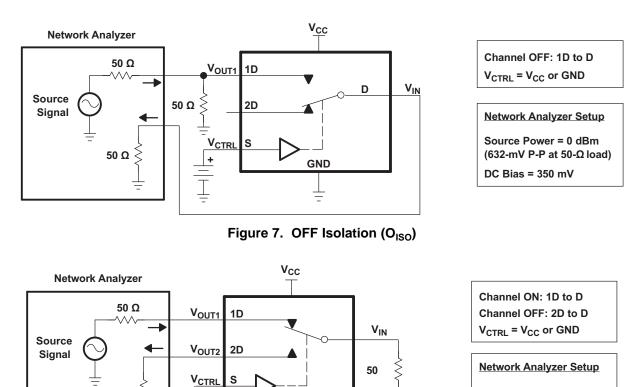


7 Parameter Measurement Information



⁽¹⁾ All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 W, t_r < 5 ns, t_f < 5 ns. ⁽²⁾ C_L includes probe and jig capacitance.

Figure 6. Turnon (T_{ON}) and Turnoff Time (T_{OFF})



Source Power = 0 dBm (632-mV P-P at 50-Ω load) DC Bias = 350 mV



50 Ω $\stackrel{>}{>}$

+

Figure 8. Crosstalk (X_{TALK})

GND

Ŧ



V_{CC} **Network Analyzer** 50 Ω V_{OUT1} 1D Channel ON: 1D to D D V_{IN} $V_{CTRL} = V_{CC} \text{ or GND}$ Source 2D Signal Network Analyzer Setup VCTRL Source Power = 0 dBm ≷ 50 Ω S (632-mV P-P at 50-Ω load) + GND DC Bias = 350 mV Ξ Ŧ Figure 9. Bandwidth (BW) 800 mV Input 50% 50% 400 mV ^tPHL VOH 50% 50% Output VOL

Parameter Measurement Information (continued)

Figure 10. Propagation Delay

NSTRUMENTS

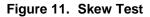
ÈXAS

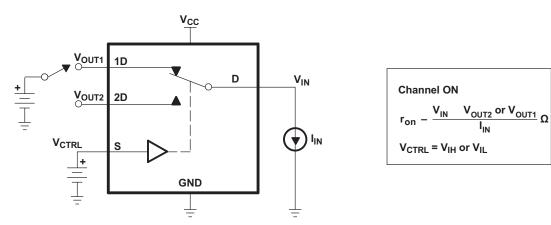
800 mV - 50% 50% Input • 400 mV ► t_{PHL} V_{OH} - 50% Output - V_{ol} $\mathbf{t}_{_{\mathsf{SK}(\mathsf{P})}} = \left| \mathbf{t}_{_{\mathsf{PHL}}} - \mathbf{t}_{_{\mathsf{PLH}}} \right|$ PULSE SKEW t_{SK(P)} - 800 mV 50% - 50% Input 400 mV ► t_{PHL1} V_{OH} 50% 50% Output 1 V_{ol} ► t_{sκ(o)} V_{OH} 50% 50% Output 2 • V_{ol} t_{PLH2} ► t_{PHL2}

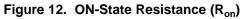
Parameter Measurement Information (continued)



OUTPUT SKEW t_{sk(P)}

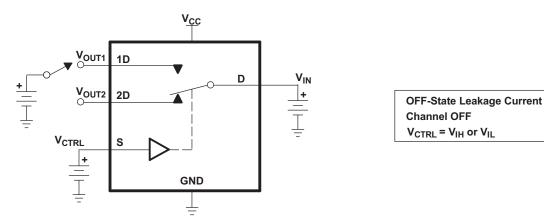














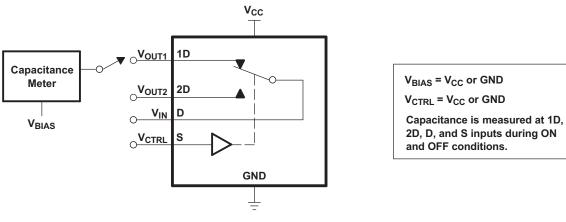


Figure 14. Capacitance

TEXAS INSTRUMENTS

www.ti.com

8 Detailed Description

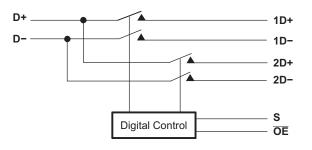
8.1 Overview

The TS3USB221E device is a 2-channel SPDT switch specially designed for the switching of high-speed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (1 GHz) of this switch allows signals to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The device also has a low power mode that reduces the power consumption to 1 μ A for portable applications with a battery or limited power budget.

The device is designed for low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480 Mbps).

The TS3USB221E device integrates ESD protection cells on all pins, is available in a tiny μ QFN package (2 mm x 1.5 mm) and is characterized over the free-air temperature range from –40°C to 85°C.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Low Power Mode

The TS3USB221E has a low power mode that reduces the power consumption to 1 μ A when the device is not in use. To put the device in low power mode and disable the switch, the bus-switch enable pin \overline{OE} must be supplied with a logic high signal.

8.4 Device Functional Modes

Table 1. Truth Table

S	ŌĒ	FUNCTION
X	Н	Disconnect
L	L	D = 1D
Н	L	D = 2D



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

There are many USB applications in which the USB hubs or controllers have a limited number of USB I/Os. The TS3USB221E solution can effectively expand the limited USB I/Os by switching between multiple USB buses in order to interface them to a single USB hub or controller. TS3USB221E can also be used to connect a single controller to two USB connectors.

9.2 Typical Application

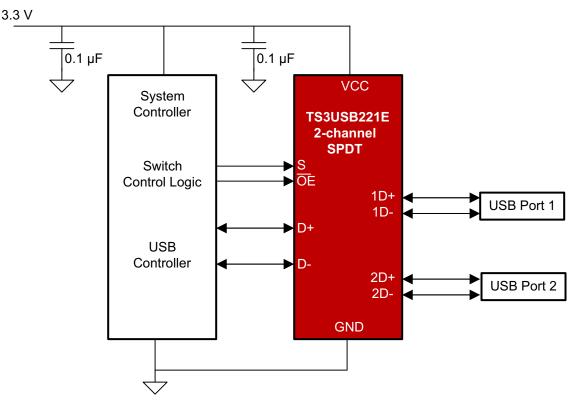


Figure 15. Simplified Schematic

9.2.1 Design Requirements

Design requirements of the USB 1.0, 1.1, and 2.0 standards should be followed.

TI recommends that the digital control pins S and \overline{OE} be pulled up to V_{CC} or down to GND to avoid undesired switch positions that could result from the floating pin.

9.2.2 Detailed Design Procedure

The TS3USB221E can be properly operated without any external components. However, it is recommended that unused pins should be connected to ground through a 50- Ω resistor to prevent signal reflections back into the device.

Copyright © 2009–2019, Texas Instruments Incorporated

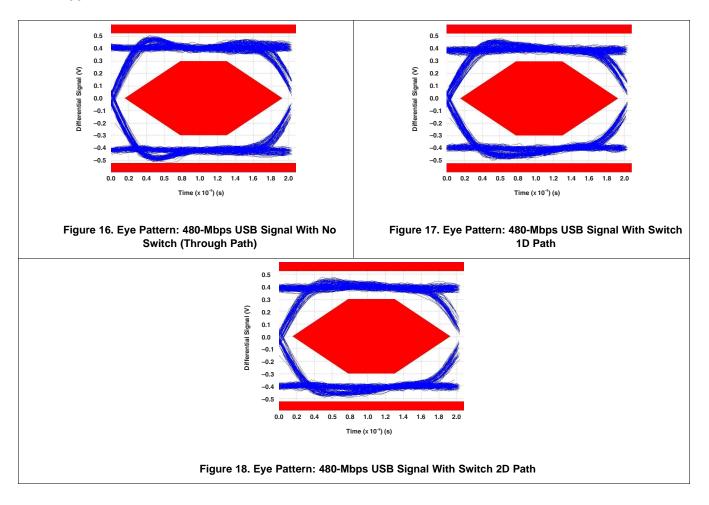
SCDS263D-SEPTEMBER 2009-REVISED SEPTEMBER 2019



www.ti.com

Typical Application (continued)

9.2.3 Application Curves





10 Power Supply Recommendations

Power to the device is supplied through the V_{CC} pin and should follow the USB 1.0, 1.1, and 2.0 standards. TI recommends placing a bypass capacitor as close as possible to the supply pin V_{CC} to help smooth out lower frequency noise to provide better load regulation across the frequency spectrum.

11 Layout

11.1 Layout Guidelines

Place supply bypass capacitors as close to V_{CC} pin as possible and avoid placing the bypass caps near the D+/D- traces.

The high speed D+/D- traces should always be matched lengths and must be no more than 4 inches; otherwise, the eye diagram performance may be degraded. A high-speed USB connection is made through a shielded, twisted pair cable with a differential characteristic impedance. In layout, the impedance of D+ and D- traces should match the cable characteristic differential impedance for optimal performance.

Route the high-speed USB signals using a minimum of vias and corners which will reduce signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points on twisted pair lines; through-hole pins are not recommended.

When it becomes necessary to turn 90°, use two 45° turns or an arc instead of making a single 90° turn. This reduces reflections on the signal traces by minimizing impedance discontinuities.

Do not route USB traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or IC's that use or duplicate clock signals.

Avoid stubs on the high-speed USB signals because they cause signal reflections. If a stub is unavoidable, then the stub should be less than 200 mm.

Route all high-speed USB signal traces over continuous planes (V_{CC} or GND), with no interruptions.

Avoid crossing over anti-etch, commonly found with plane splits.

Due to high frequencies associated with the USB, a printed circuit board with at least four layers is recommended; two signal layers separated by a ground and power layer as shown in Figure 19.

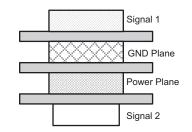


Figure 19. Four-Layer Board Stack-Up

The majority of signal traces should run on a single layer, preferably Signal 1. Immediately next to this layer should be the GND plane, which is solid with no cuts. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies. For more information on layout guidelines, see *High Speed Layout Guidelines* (SCAA082) and *USB 2.0 Board Design and Layout Guidelines* (SPRAAR7).

SCDS263D - SEPTEMBER 2009 - REVISED SEPTEMBER 2019

www.ti.com

ISTRUMENTS

EXAS

11.2 Layout Example

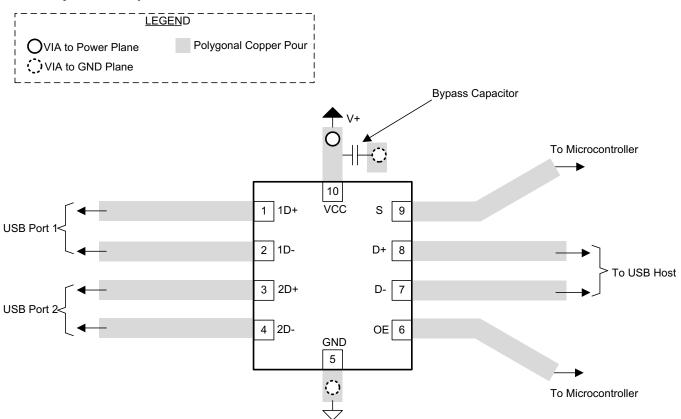


Figure 20. Package Layout Diagram



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation, see the following:

- Implications of Slow or Floating CMOS Inputs, SCBA004
- High Speed Layout Guidelines, SCAA082
- USB 2.0 Board Design and Layout Guidelines, SPRAAR7

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.4 Trademarks

E2E is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TS3USB221EDRCR	ACTIVE	VSON	DRC	10	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZVM	Samples
TS3USB221ERSER	ACTIVE	UQFN	RSE	10	3000	RoHS & Green	NIPDAU NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(LGO, LGR, LGV)	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



PACKAGE OPTION ADDENDUM

10-Dec-2020



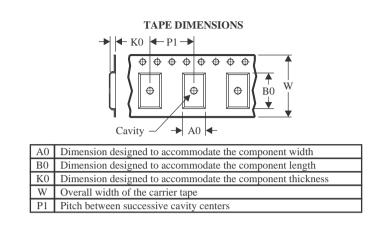
Texas

*All dimensions are nominal

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3USB221EDRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TS3USB221ERSER	UQFN	RSE	10	3000	179.0	8.4	1.75	2.25	0.65	4.0	8.0	Q1
TS3USB221ERSER	UQFN	RSE	10	3000	180.0	8.4	1.68	2.13	0.76	4.0	8.0	Q1
TS3USB221ERSER	UQFN	RSE	10	3000	180.0	9.5	1.7	2.2	0.75	4.0	8.0	Q1



PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3USB221EDRCR	VSON	DRC	10	3000	356.0	356.0	35.0
TS3USB221ERSER	UQFN	RSE	10	3000	200.0	183.0	25.0
TS3USB221ERSER	UQFN	RSE	10	3000	202.0	201.0	28.0
TS3USB221ERSER	UQFN	RSE	10	3000	189.0	185.0	36.0

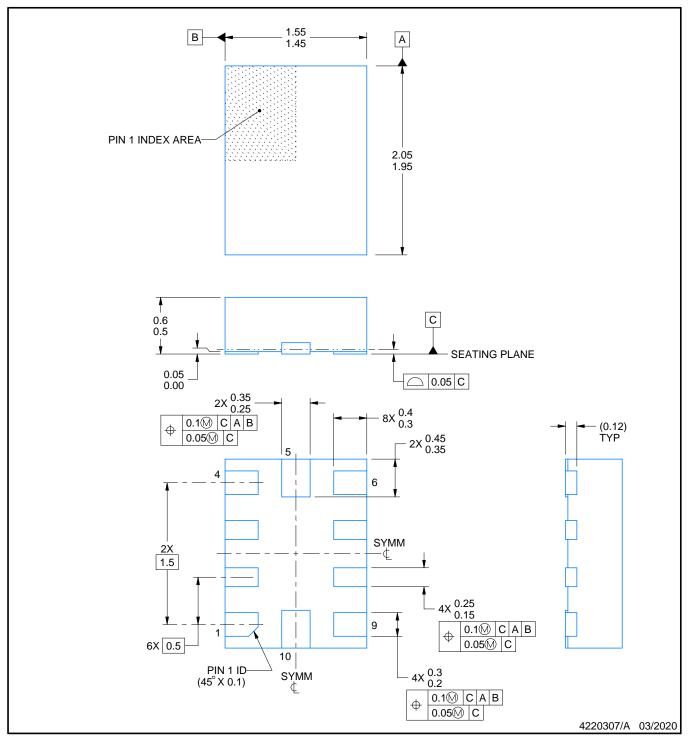
RSE0010A



PACKAGE OUTLINE

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

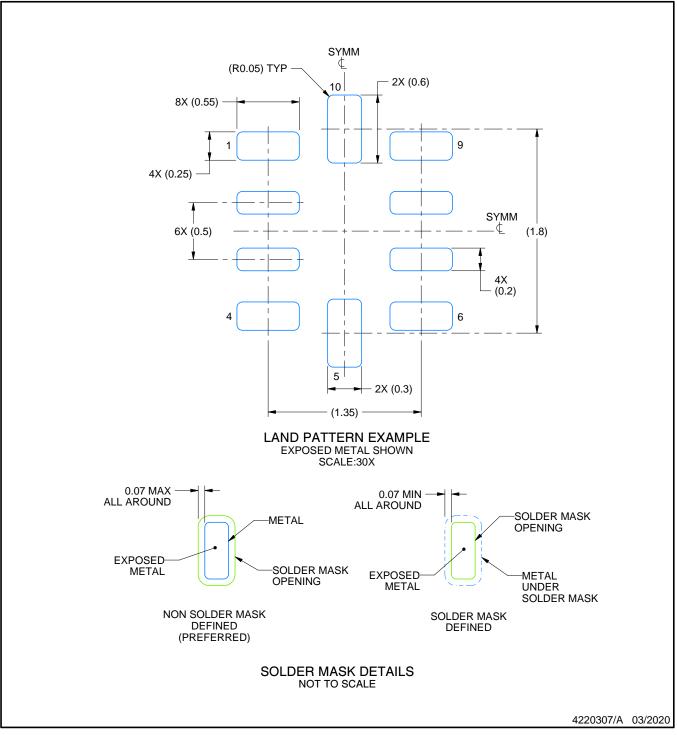


RSE0010A

EXAMPLE BOARD LAYOUT

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

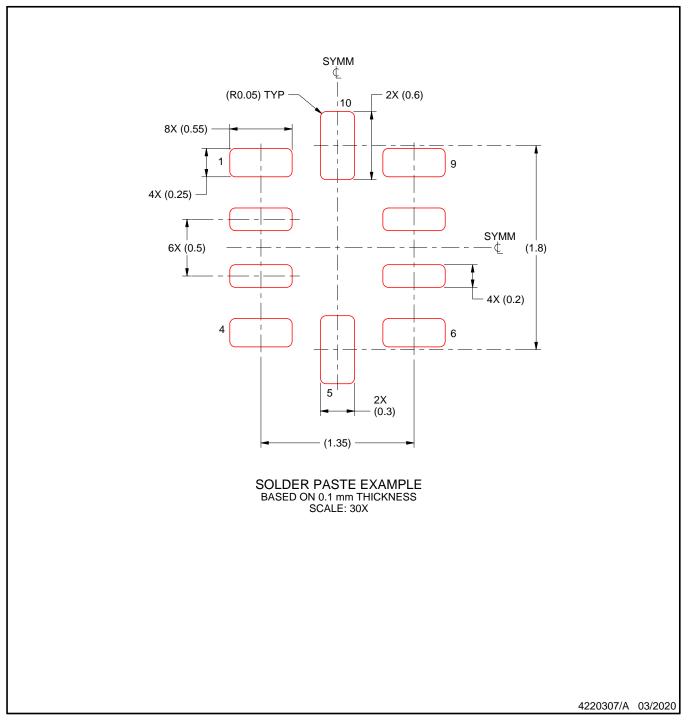


RSE0010A

EXAMPLE STENCIL DESIGN

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



DRC 10

3 x 3, 0.5 mm pitch

GENERIC PACKAGE VIEW

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





DRC0010J



PACKAGE OUTLINE

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.

3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



DRC0010J

EXAMPLE BOARD LAYOUT

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



DRC0010J

EXAMPLE STENCIL DESIGN

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022, Texas Instruments Incorporated